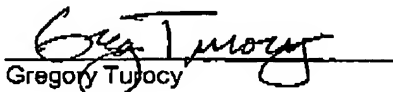


DEC 19 2005

CERTIFICATE OF FACSIMILE

I hereby certify that this correspondence (along with any paper referred to as being attached or enclosed) is being transmitted via facsimile to: Mail Stop Amendment, Commissioner for Patents, P.O. Box 1450, Alexandria, Virginia 22313-1450 at (571)-273-8300.

Date: Dec 19 2005  
Gregory Turocy**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

In re patent application of:

Applicant: Avanzino, *et al.*

Examiner: Stanley J. Pruchnic

Serial No: 10/755,215

Art Unit: 2859

Filing Date: January 12, 2004

Title: **FABRICATION OF TEMPERATURE SENSING RESISTIVE ELEMENTS  
ON A HIGH POWER DISSIPATION DEVICE TO MONITOR TEMPERATURE  
GRADIENTS**

Mail Stop Amendment  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

---

**DECLARATION UNDER 37 C.F.R. §1.131**

---

Dear Sir:

We, Steven C. Avanzino and Bharath Rangarajan, declare and say as follows:

(1) We are the inventors of the claims of the above-identified patent application. This Declaration is submitted to establish conception of the invention described and claimed in the above-captioned application in the United States at a date prior to October 30, 2003, which is the date of patent of Chey et al. (U.S. Patent

10/755,215

H0262

6,928,380 B2) and to establish diligence from at least just prior to October 30, 2003 until constructive reduction to practice, January 12, 2004.

(2) To establish conception of the invention claimed in the above-identified application prior to October 30, 2003, copies of the relevant portions of an Invention Disclosure describing the invention are enclosed with this Declaration as Exhibit A. Conception and the written description of the invention contained in the Exhibit A were completed prior to October 30, 2003 in this country. Certain information, such as the actual dates and proprietary information, contained on the documents has been removed from the copies.

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(4) In view of Exhibit A, it can be seen that the invention claimed in the present application was indeed conceived prior to October 30, 2003.

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We, Steven C. Avanzino and Bharath Rangarajan, hereby declare that all statements made herein of our own knowledge are true and that all statements made on information and belief are believed to be true; and further that these statements were made with knowledge that willful false statements and the like are punishable by fine or imprisonment, or both, under Section 1001 of Title 18 of the United States Code, and that such willful false statements may jeopardize the validity of the application or any patent issued therein.

\_\_\_\_\_  
Steven C. Avanzino

\_\_\_\_\_  
Date

\_\_\_\_\_  
Bharath Rangarajan

\_\_\_\_\_  
Date

## PRIORITY CODE

A \_\_\_\_\_ B 39  
C \_\_\_\_\_ D \_\_\_\_\_

Technical Leader: BHANWAR SINGH—CLASSROOM C-1&amp;2

## AMD INVENTION DISCLOSURE

TLD ID#

H0262

Rec'd date: \_\_\_\_\_

California &amp; Asia: x42110, return to MS68;

Texas: x55964 return to MS562;

Dresden &amp; Europe: x83401 Silke Kretzschmar at MS B21-PP.

This invention applies to: Project: ☐, Product: ☐, Process: ☐, Technology ☐, Other ☐.

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→ INVENTOR/SESSION PARTICIPANT ADDRESS INFORMATION IS ON THE NEXT PAGE (1A) ←

→ Device to Monitor Temperature Gradients

Inventor's signature: \_\_\_\_\_ date: \_\_\_\_\_

Inventor's printed full name: Steve Avanzino Citizenship: \_\_\_\_\_

Employee #: \_\_\_\_\_ Extension: \_\_\_\_\_ Mail stop: \_\_\_\_\_ Home telephone: ( ) \_\_\_\_\_

AMD email address: \_\_\_\_\_ AMD office FAX: ( ) \_\_\_\_\_

Division: \_\_\_\_\_ Directorate: \_\_\_\_\_ Dept #: \_\_\_\_\_ Dept: \_\_\_\_\_ Manager: \_\_\_\_\_

Residence address: \_\_\_\_\_

Post Office address: \_\_\_\_\_

Co-Inventor's signature: Bharath Rangarajan date: \_\_\_\_\_

Co-Inventor's printed full name: \_\_\_\_\_ Citizenship: \_\_\_\_\_

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Residence address: \_\_\_\_\_

Post Office address: \_\_\_\_\_

HARVESTING LAW FIRM/ATTORNEYS: AMIN &amp; TUROCY:

Himanshu Amin, Deborah Corpus and Greg Turocy

Witness 1 initial: StuWitness 2 initial: W

AMD CONFIDENTIAL Attorney-Client Privileged Information

Page 1

**AMD INVENTION DISCLOSURE**

TLD ID#

Rec'd date

California &amp; Asia: x42110, return to MS68;

Texas: x55964 return to MS562;

Dresden &amp; Europe: x83401 Silke Kretzschmar at MS E21-PP.

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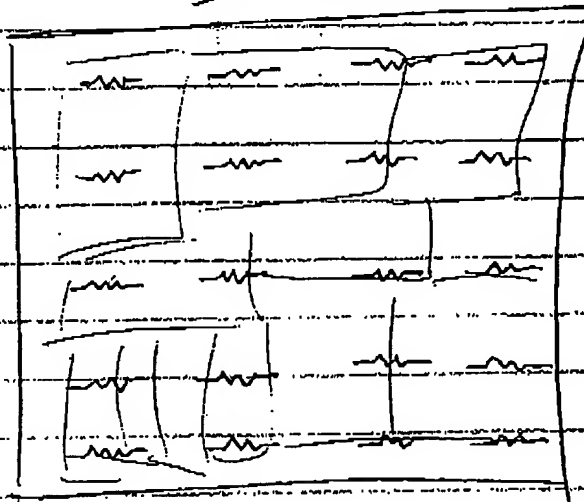
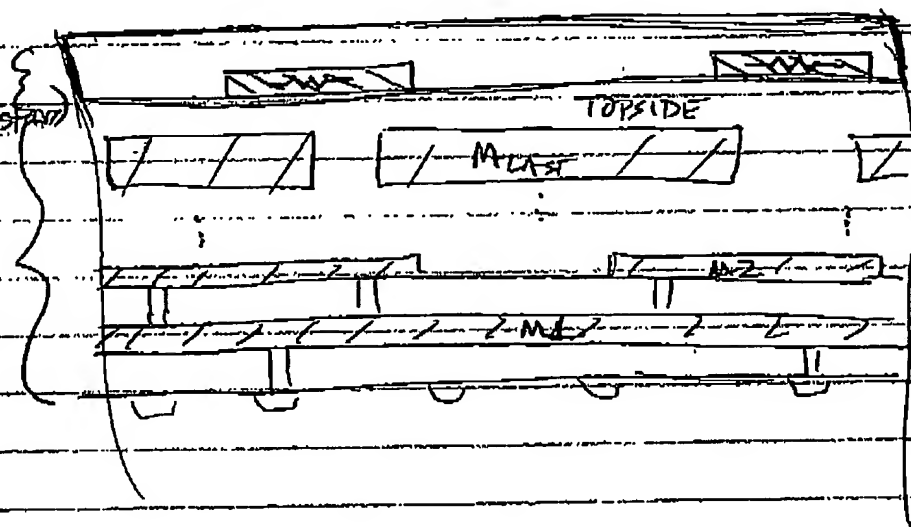
Patent notebook # \_\_\_\_\_ Page numbers \_\_\_\_\_ Number of drawings \_\_\_\_\_

Witness 1 initial: \_\_\_\_\_ Witness 2 initial: \_\_\_\_\_

**AMD** CONFIDENTIAL: Attorney-Client Privileged Information Page 2

39

IC Device

Temp Sensor  
Layer (Kelvin Resistor)Integrated  
Circuit  
(uProcessor)

FRIDAY, MAY 3, 2002

ADVANCED INTEGRATION METROLOGY PATENT HARVESTING SESSION

Technical Leader: BHANWAR SINGH—CLASSROOM C-1&amp;2

PRIORITY CODE

A \_\_\_\_\_ B 39  
C \_\_\_\_\_ D \_\_\_\_\_

## AMD INVENTION DISCLOSURE

TLD ID#

H0262

Rec'd date \_\_\_\_\_

California &amp; Asia: x42110, return to MS68;

Texas: x55964 return to MS562;

Dresden &amp; Europe: x83401 Silke Kretzschmar at MS E21-PP.

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→ INVENTOR/SESSION PARTICIPANT ADDRESS INFORMATION IS ON THE NEXT PAGE (1A) ←

→ Device to Monitor Temperature Gradients

Inventor's signature: \_\_\_\_\_ date: \_\_\_\_\_

Inventor's printed full name: Steve Avanzino Citizenship: \_\_\_\_\_

Employee #: \_\_\_\_\_ Extension: \_\_\_\_\_ Mail stop: \_\_\_\_\_ Home telephone: ( ) \_\_\_\_\_

AMD email address: \_\_\_\_\_ AMD office FAX: ( ) \_\_\_\_\_

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Residence address: \_\_\_\_\_

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Co-Inventor's signature: Bharath Rangarajan date: \_\_\_\_\_

Co-Inventor's printed full name: \_\_\_\_\_ Citizenship: \_\_\_\_\_

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HARVESTING LAW FIRM/ATTORNEYS: AMIN &amp; TUROCY:

Himanshu Amin, Deborah Corpus and Greg Turocy

Witness 1 initial: STWitness 2 initial: MT

TLD cover page. Revised Jan 10/29/01.

AMD CONFIDENTIAL: Attorney-Client Privileged Information

Page 1

**AMD INVENTION DISCLOSURE**

TLD ID#

Rec'd date

California &amp; Asia: x42110, return to MS68;

Texas: x55964 return to MS562;

Dresden &amp; Europe: x83401 Silke Kretzschmar at MS E21-PP.

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Patent notebook #

Page numbers

Number of drawings

Witness 1 initial:

Witness 2 initial:

JDK:hardcopy:10/24/05, reviewed on: 10/25/05

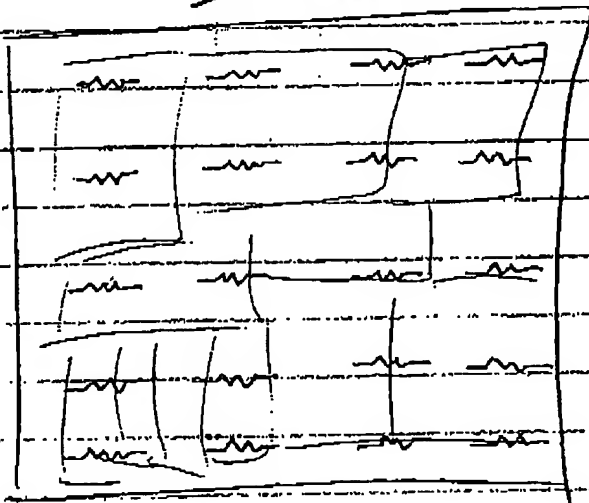
**AMD** CONFIDENTIAL: Attorney-Client Privileged Information

Page 2



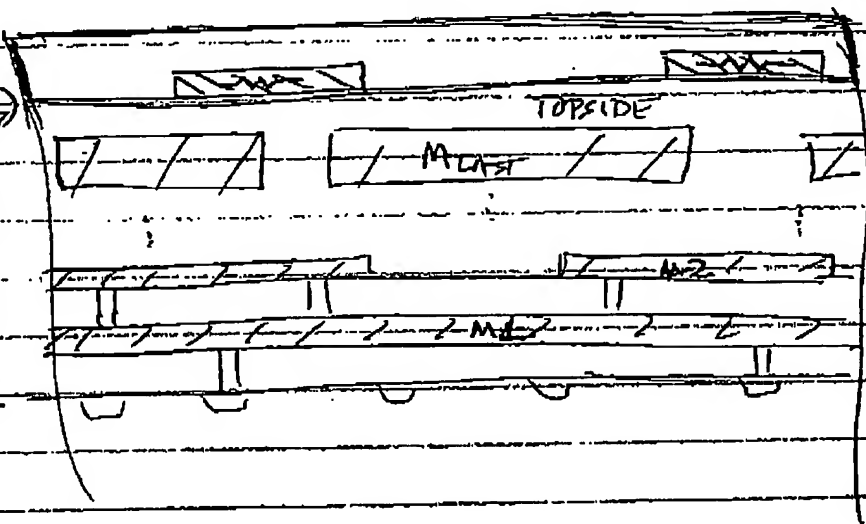
39

IC Device



Temp Sensor Layer (Kelvin Resistor)


Integrated Circuit (uProcessor)



DEC 19 2005

CERTIFICATE OF FACSIMILE

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Date: Dec 19 2005  
Gregory Turocy**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

In re patent application of:

Applicant: Avanzino, *et al.*

Examiner: Stanley J. Pruchnic

Serial No: 10/755,215

Art Unit: 2859

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Title: **FABRICATION OF TEMPERATURE SENSING RESISTIVE ELEMENTS  
ON A HIGH POWER DISSIPATION DEVICE TO MONITOR TEMPERATURE  
GRADIENTS**

Mail Stop Amendment  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

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**DECLARATION UNDER 37 C.F.R. §1.131**

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(1) We are the inventors of the claims of the above-identified patent application. This Declaration is submitted to establish conception of the invention described and claimed in the above-captioned application in the United States at a date prior to October 30, 2003, which is the date of patent of Chey et al. (U.S. Patent

10/755,215

H0262

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H0262

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Steven C. Avanzino

11/28/05  
Date

  
Bharath Rangarajan

11/28/05  
Date

## PRIORITY CODE

A 39 B 39  
C 39 D 39

Technical Leader: BHANWAR SINGH—CLASSROOM C-1&amp;2

## AMD INVENTION DISCLOSURE

TLD ID#

H0262

Rec'd date

California &amp; Asia: x42110, return to MS68;

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→ Device to Monitor Temperature Gradients

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Inventor's printed full name: Steve Avanzino Citizenship: \_\_\_\_\_

Employee #: \_\_\_\_\_ Extension: \_\_\_\_\_ Mail stop: \_\_\_\_\_ Home telephone: ( ) \_\_\_\_\_

AMD email address: \_\_\_\_\_ AMD office FAX: ( ) \_\_\_\_\_

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Residence address: \_\_\_\_\_

Post Office address: \_\_\_\_\_

Co-Inventor's signature: Bharath Rangarajan date: \_\_\_\_\_

Co-Inventor's printed full name: \_\_\_\_\_ Citizenship: \_\_\_\_\_

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HARVESTING LAW FIRM/ATTORNEYS: AMIN &amp; TUROCY:

Himanshu Amin, Deborah Corpus and Greg Turocy

Witness 1 initial: ST Witness 2 initial: HT

AMD CONFIDENTIAL Attorney-Client Privileged Information

Page 1

**AMD INVENTION DISCLOSURE**

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Patent notebook # Page numbers Number of drawings

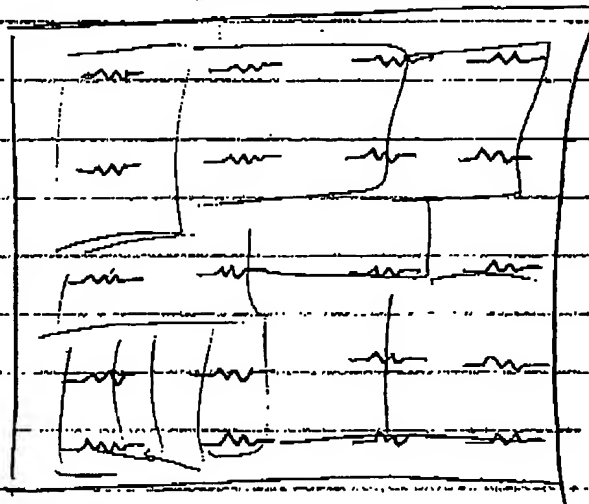
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**AMD** CONFIDENTIAL Attorney-Client Privileged Information

Page 2

39

IC Device

Temp Sensor  
Layer (Kelvin Resistor)Integrated  
Circuit  
(Processor)